


<b>Search Notes</b> 	<b>Application/Control No.</b> 10616101	<b>Applicant(s)/Patent Under Reexamination</b> LUO ET AL.
	<b>Examiner</b> IQBAL H CHOWDHURY	<b>Art Unit</b> 1652

SEARCHED			
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SEARCH NOTES		
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STN/WEST databases- updated search of 8/31/2007	3/11/2008	IC

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